

<b>Notic of R ferenc s Cited</b>	Application/Control No. 09/929,356	Applicant(s)/Patent Under Reexamination YANAGINO ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	X	Palmer, Michael. "Get It Right: Use Monte Carlo Simulation When Projecting Hotel Construction Loans." The Journal of Lending & Credit Risk Management, vol. 81, no. 5, page 38(7), January 1999.

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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